Contents:

1. Computation and Confirmation of Conduction Band Offset and Oxide Breakdown Fields from a Combination of Electrical and Physical Measurements on a N-Type C-Face 4H-SiC MOS Device
   Dr. Ravi Kumar Chanana
   01-06

2. Comparative Study of FPGA Performance Over ASIC and DSP Processors
   Dr. Faris Ali Jasim Shaban
   07-13

3. Impact of Single DG on the Reliability of the distribution system
   Atik Faisal, Min Yongzhi
   14-19

   Onah. C. O., Obe. E. S., Agber. J. U.
   20-27

5. Reliability Indices evaluation of Ring Distribution Systems without and with DG
   Suadhu K. Moussa, Moner A Faraj, Fathi K. Amoura, Wafa S. Shuaib
   28-41

6. Analysis and Improvement of Power Quality Parameters by Using UPQC with the Implementation of Fuzzy and PID Controllers
   Ravindra Kajla, Subhash
   42-52

7. Comparative Analysis of Power Quality Parameters by Using UPQC with The Implementation of Fuzzy and PID Controllers
   Ravindra Kajla, Subhash
   53-60

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